



Vincotech

30-E312NIB560H710-PR40F07Z

datasheet

flowNPC E3BP

1200 V / 560 A

Topology features

- Low side Kelvin Emitter for improved switching performance
- Neutral Point Clamped Topology (I-Type)
- Split topology
- Temperature sensor

Component features

- High speed switching
- Low collector emitter saturation voltage
- Low turn-off losses
- Optimized for hard switching topologies
- Positive temperature coefficient

Housing features

- Base isolation: Al_2O_3
- Cu baseplate
- Convex shaped baseplate for superior thermal contact
- CTI600 housing material
- Baseplate with rough surface
- Thermo-mechanical push-and-pull force relief
- Solder pin

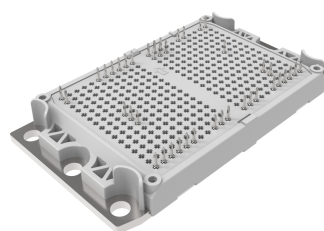
Target applications

- Energy Storage Systems

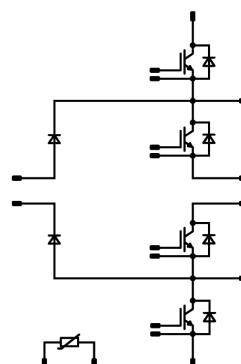
Types

- 30-E312NIB560H710-PR40F07Z

flow E3BP 12 mm housing



Schematic





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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Buck Switch				
Collector-emitter voltage	V_{CES}		1200	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	315	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	1680	A
Turn off safe operating area		$T_j = 150\text{ °C}$, $V_{CE} = 1200\text{ V}$	1680	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	484	W
Gate-emitter voltage	V_{GES}		± 20	V
Maximum junction temperature	T_{jmax}		175	°C

Buck Diode

Peak repetitive reverse voltage	V_{RRM}		1200	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	203	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	1680	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	358	W
Maximum junction temperature	T_{jmax}		175	°C

Boost Switch

Collector-emitter voltage	V_{CES}		1200	V
Collector current (DC current)	I_C	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	315	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	1680	A
Turn off safe operating area		$T_j = 150\text{ °C}$, $V_{CE} = 1200\text{ V}$	1680	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	484	W
Gate-emitter voltage	V_{GES}		± 20	V
Maximum junction temperature	T_{jmax}		175	°C



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Maximum Ratings

$T_j = 25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Boost Diode				
Peak repetitive reverse voltage	V_{RRM}		1200	V
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Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	358	W
Maximum junction temperature	T_{jmax}		175	°C

Boost Sw. Inv. Diode

Peak repetitive reverse voltage	V_{RRM}		1200	V
Forward current (DC current)	I_F	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	203	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	1680	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ $T_s = 80\text{ °C}$	358	W
Maximum junction temperature	T_{jmax}		175	°C

Module Properties

Thermal Properties

Storage temperature	T_{stg}		-40...+125	°C
Operation temperature under switching condition	T_{jop}		-40...+($T_{jmax} - 25$)	°C

Isolation Properties

Isolation voltage	V_{isol}	DC Test Voltage* $t_p = 2\text{ s}$	6800	V
Creepage distance			>12,7	mm
Clearance			>12,7	mm
Comparative Tracking Index	CTI		≥ 600	

*100 % tested in production



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	

Buck Switch

Static

Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$			0,0048	25	4,7	5,5	6,2	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		560	25 125 150		1,62 1,76 1,78	2,15 ⁽¹⁾	V
Collector-emitter cut-off current	I_{CES}		0	1200		25			16	µA
Gate-emitter leakage current	I_{GES}		20	0		25			400	nA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	$f = 100 \text{ kHz}$	0	25		25		74000		pF
Output capacitance	C_{oes}							1268		pF
Reverse transfer capacitance	C_{res}							376		pF
Gate charge	Q_g	$V_{CC} = 960 \text{ V}$	0/15		560	25		4128		nC

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 5,2 \text{ W/mK}$ (PTM)						0,2		K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$	$R_{gon} = 2 \text{ Ω}$ $R_{goff} = 2 \text{ Ω}$	±15	600	560	25 125 150		417,08 417,24 418,87		ns
Rise time	t_r					25 125 150		38,77 40,29 40,82		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		337,1 374,67 385,03		ns
Fall time	t_f					25 125 150		30,36 55,22 63,62		ns
Turn-on energy (per pulse)	E_{on}	$Q_{tFWD} = 14,88 \text{ µC}$ $Q_{tFWD} = 36,83 \text{ µC}$ $Q_{tFWD} = 43,43 \text{ µC}$				25 125 150		22,75 26,88 29,49		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		19,24 31,03 34,96		mWs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	

Buck Diode

Static

Forward voltage	V_F				144	25 125 150		1,88 1,63 1,55	2 ⁽¹⁾	V
Reverse leakage current	I_R	$V_r = 1200$ V				25			16	µA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 5,2$ W/mK (PTM)						0,27		K/W
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Dynamic

Peak recovery current	I_{RM}	$di/dt=13246$ A/µs $di/dt=13511$ A/µs $di/dt=14517$ A/µs	± 15	600	560	25 125 150		392,57 594,8 636,79		A
Reverse recovery time	t_{rr}					25 125 150		77,76 147,67 162,64		ns
Recovered charge	Q_r					25 125 150		14,88 36,83 43,43		µC
Reverse recovered energy	E_{rec}					25 125 150		5,62 15,92 18,89		mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25 125 150		13524,74 12801,77 12183,08		A/µs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	

Boost Switch

Static

Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}$			0,0048	25	4,7	5,5	6,2	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		560	25 125 150		1,62 1,76 1,78	2,15 ⁽¹⁾	V
Collector-emitter cut-off current	I_{CES}		0	1200		25			16	µA
Gate-emitter leakage current	I_{GES}		20	0		25			400	nA
Internal gate resistance	r_g							None		Ω
Input capacitance	C_{ies}	$f = 100 \text{ kHz}$	0	25		25		74000		pF
Output capacitance	C_{oes}							1268		pF
Reverse transfer capacitance	C_{res}							376		pF
Gate charge	Q_g	$V_{CC} = 960 \text{ V}$	0/15		560	25		4128		nC

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 5,2 \text{ W/mK}$ (PTM)						0,2		K/W
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Dynamic

Turn-on delay time	$t_{d(on)}$	$R_{gon} = 3,05 \Omega$ $R_{goff} = 16 \Omega$	± 15	600	560	25 125 150		663,95 661,45 661,6		ns
Rise time	t_r					25 125 150		64,95 66,67 67,41		ns
Turn-off delay time	$t_{d(off)}$					25 125 150		2321,26 2435,47 2467,43		ns
Fall time	t_f					25 125 150		52,24 35,59 45,29		ns
Turn-on energy (per pulse)	E_{on}	$Q_{tFWD} = 12,84 \mu\text{C}$ $Q_{tFWD} = 31,15 \mu\text{C}$ $Q_{tFWD} = 37,8 \mu\text{C}$				25 125 150		20,79 22,46 24,5		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		38,29 52,01 50,52		mWs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	

Boost Diode

Static

Forward voltage	V_F				144	25 125 150		1,88 1,63 1,55	2 ⁽¹⁾	V
Reverse leakage current	I_R	$V_r = 1200$ V				25			16	μA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 5,2$ W/mK (PTM)						0,27		K/W
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Dynamic

Peak recovery current	I_{RM}	$di/dt=8772$ A/μs $di/dt=9585$ A/μs $di/dt=8606$ A/μs	± 15	600	560	25 125 150		270,52 394,42 425,31		A
Reverse recovery time	t_{rr}					25 125 150		94,49 166,77 192,27		ns
Recovered charge	Q_r					25 125 150		12,84 31,15 37,8		μC
Reverse recovered energy	E_{rec}					25 125 150		4,9 12,03 14,4		mWs
Peak rate of fall of recovery current	$(di_{rr}/dt)_{max}$					25 125 150		6194,13 6130,73 5980,73		A/μs



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Characteristic Values

Parameter	Symbol	Conditions					Values			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	

Boost Sw. Inv. Diode

Static

Forward voltage	V_F				144	25 125 150		1,88 1,63 1,55	2 ⁽¹⁾	V
Reverse leakage current	I_R	$V_i = 1200$ V				25			16	µA

Thermal

Thermal resistance junction to sink ⁽²⁾	$R_{th(j-s)}$	$\lambda_{paste} = 5,2$ W/mK (PTM)						0,27		K/W
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Thermistor

Static

Rated resistance	R					25		22		kΩ
Deviation of R100	$\Delta_{R/R}$	$R_{100} = 1484$ Ω				100	-5		5	%
Power dissipation	P					25		130		mW
Power dissipation constant	d					25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %						3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %						4000		K
Vincotech Thermistor Reference									I	

⁽¹⁾ Value at chip level

⁽²⁾ Only valid with pre-applied Vincotech thermal interface material.



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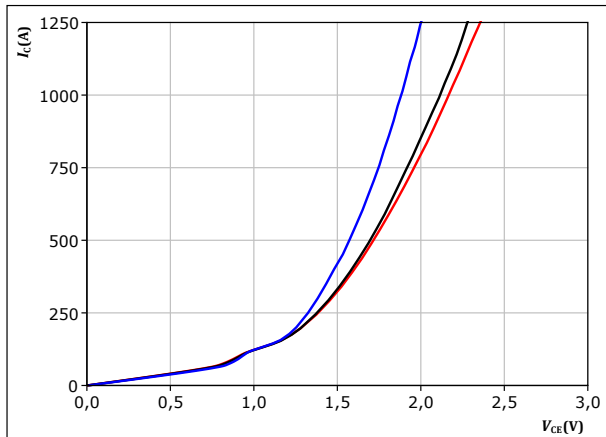
datasheet

Buck Switch Characteristics

figure 1. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

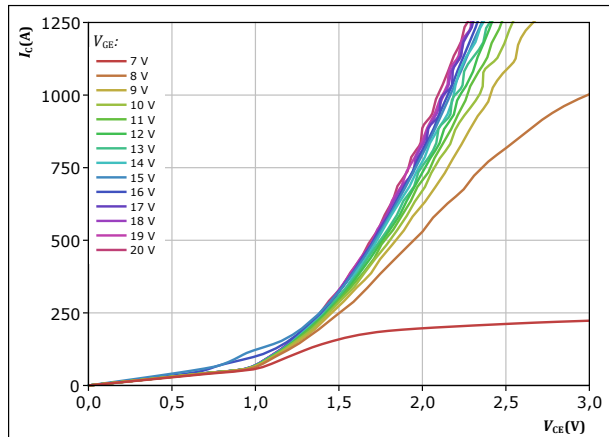


$t_p = 250 \mu s$
 $V_{GE} = 15 V$
 T_j : 25 °C, 125 °C, 150 °C

figure 2. IGBT

Typical output characteristics

$$I_C = f(V_{CE})$$

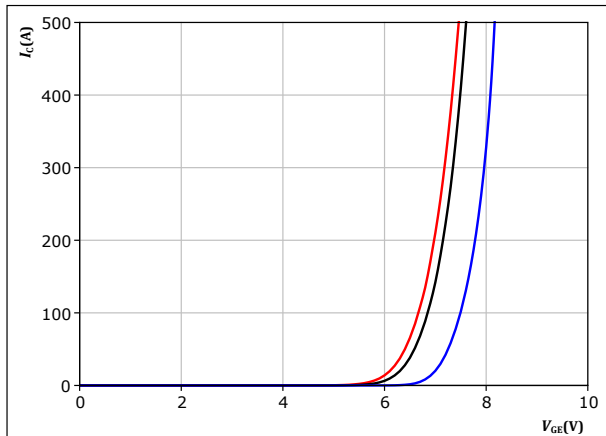


$t_p = 250 \mu s$
 $T_j = 150 \text{ °C}$
 V_{GE} from 7 V to 20 V in steps of 1 V

figure 3. IGBT

Typical transfer characteristics

$$I_C = f(V_{GE})$$

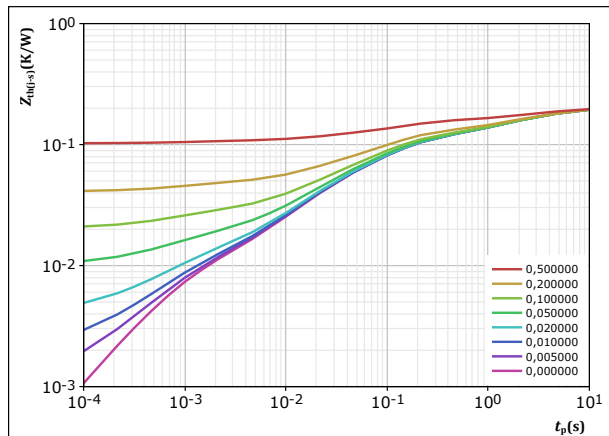


$t_p = 250 \mu s$
 $V_{CE} = 10 V$
 T_j : 25 °C, 125 °C, 150 °C

figure 4. IGBT

Transient thermal impedance as a function of pulse width

$$Z_{th(j-s)} = f(t_p)$$



$D = t_p / T$
 $R_{th(j-s)} = 0,196 \text{ K/W}$
IGBT thermal model values

$R \text{ (K/W)}$	$\tau \text{ (s)}$
4,60E-02	6,73E+00
5,45E-02	1,39E+00
7,18E-02	1,04E-01
2,52E-02	1,75E-02
7,38E-03	8,20E-04



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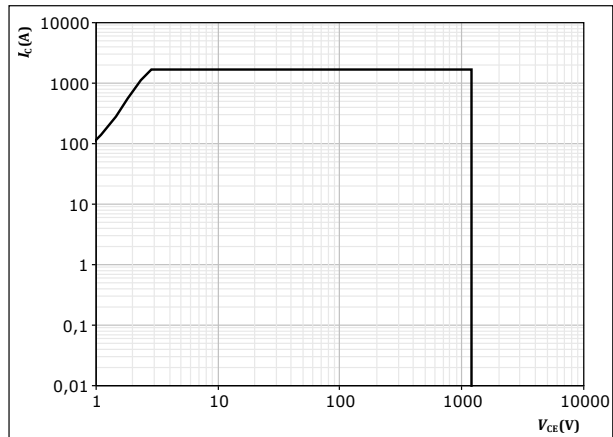
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datasheet

Buck Switch Characteristics

figure 5. IGBT

Safe operating area

$$I_C = f(V_{CE})$$



$D = \text{single pulse}$

$T_s = 80 \text{ } ^\circ\text{C}$

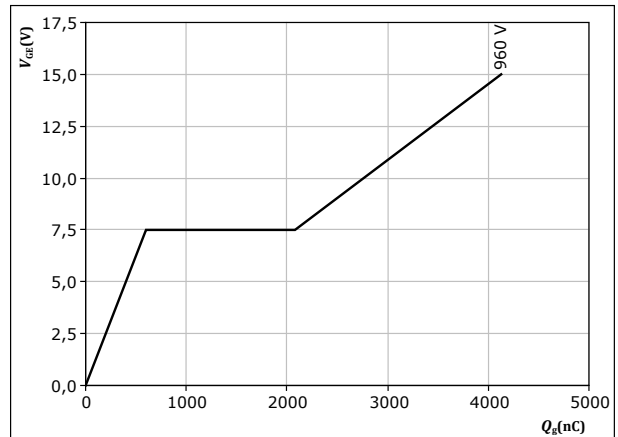
$V_{GE} = 15 \text{ V}$

$T_j = T_{jmax}$

figure 6. IGBT

Gate voltage vs gate charge

$$V_{GE} = f(Q_g)$$



$I_C = 560 \text{ A}$

$T_j = 25 \text{ } ^\circ\text{C}$



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Buck Diode Characteristics

figure 7. FWD

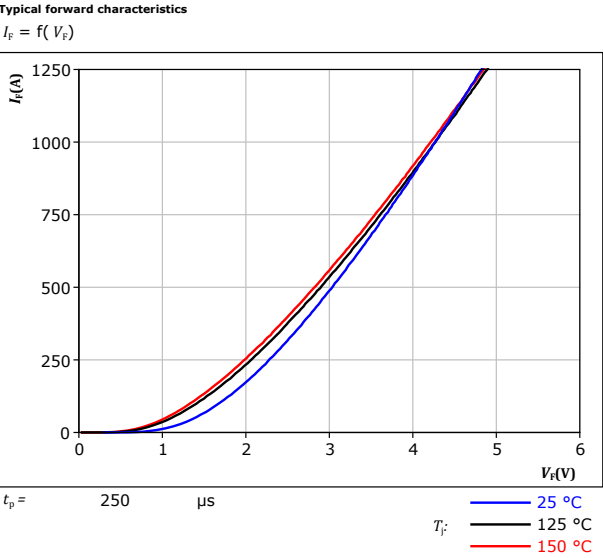
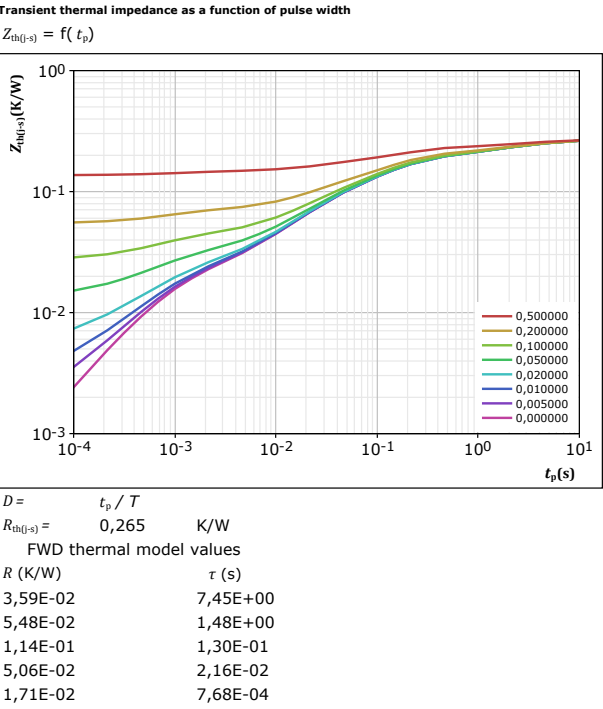


figure 8. FWD





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Boost Switch Characteristics

figure 9. IGBT

Typical output characteristics

$I_C = f(V_{CE})$

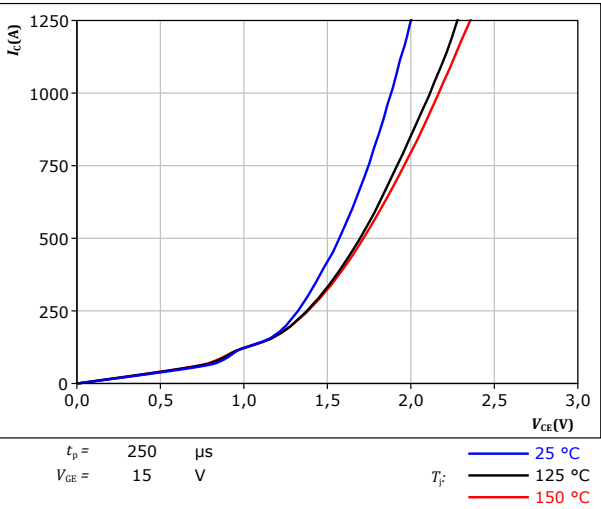


figure 10. IGBT

Typical output characteristics

$I_C = f(V_{CE})$

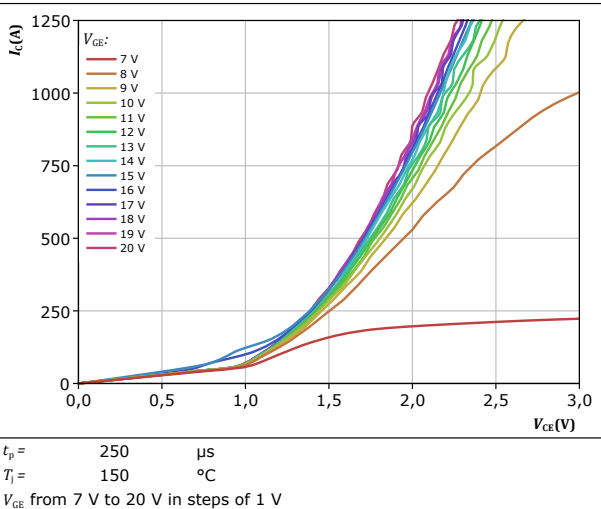


figure 11. IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

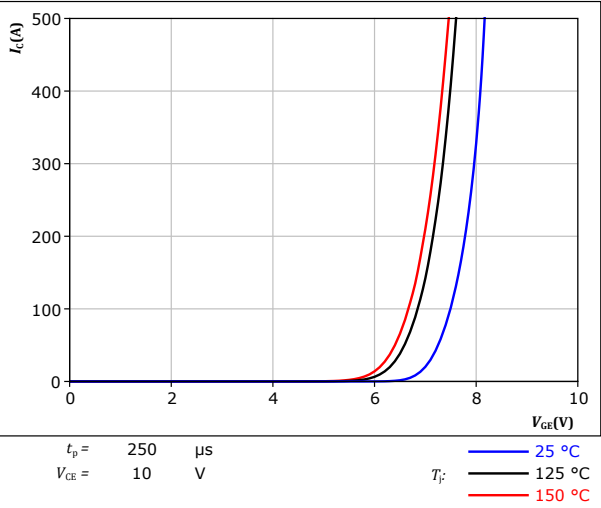
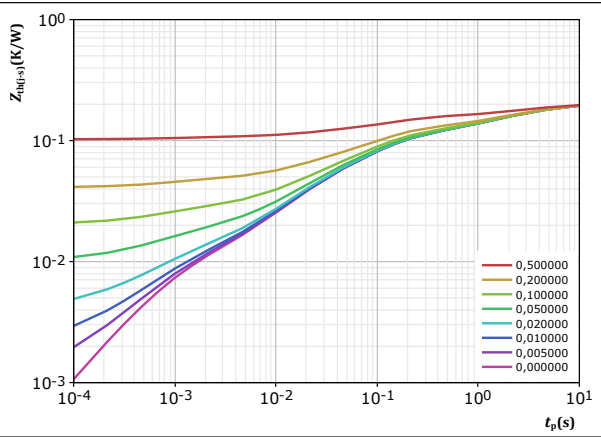


figure 12. IGBT

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



IGBT thermal model values

$R \text{ (K/W)}$	$\tau \text{ (s)}$
4,60E-02	6,73E+00
5,45E-02	1,39E+00
7,18E-02	1,04E-01
2,52E-02	1,75E-02
7,38E-03	8,20E-04



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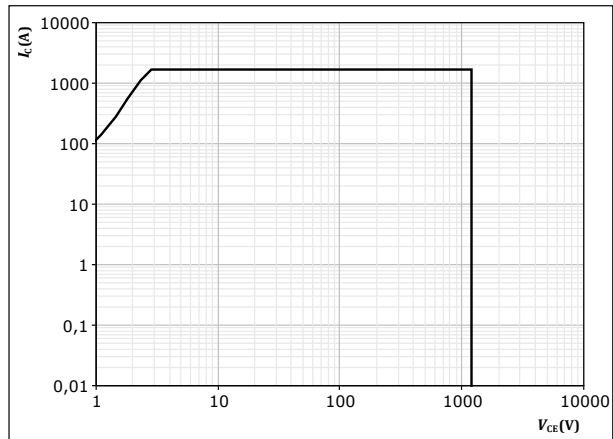
Boost Switch Characteristics

figure 13.

IGBT

Safe operating area

$$I_C = f(V_{CE})$$



$D = \text{single pulse}$

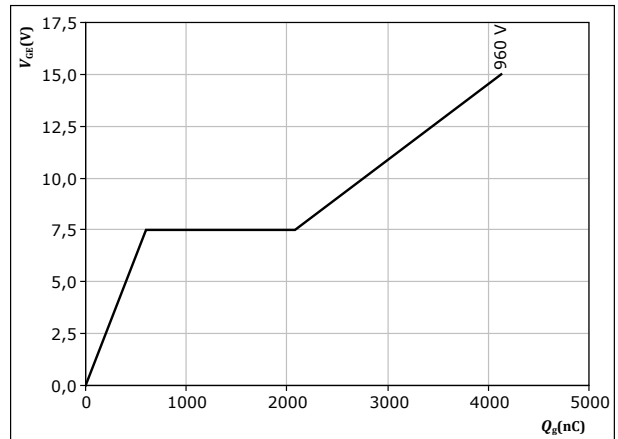
$T_s = 80 \text{ } ^\circ\text{C}$
 $V_{GE} = 15 \text{ V}$
 $T_j = T_{jmax}$

figure 14.

IGBT

Gate voltage vs gate charge

$$V_{GE} = f(Q_g)$$



$I_C = 560 \text{ A}$
 $T_j = 25 \text{ } ^\circ\text{C}$



Boost Diode Characteristics

figure 15. FWD

Typical forward characteristics
 $I_F = f(V_F)$

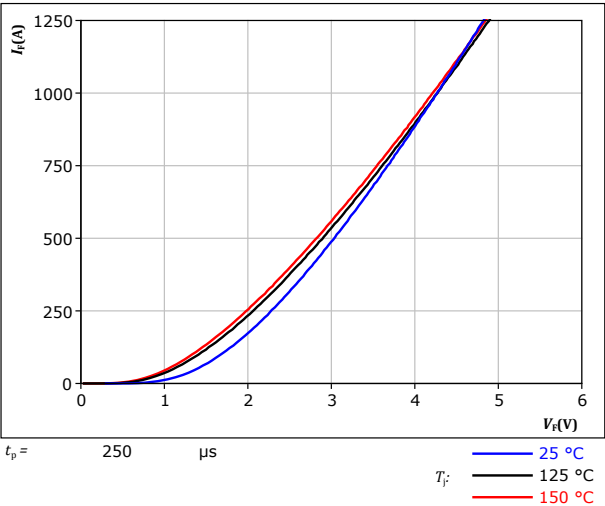
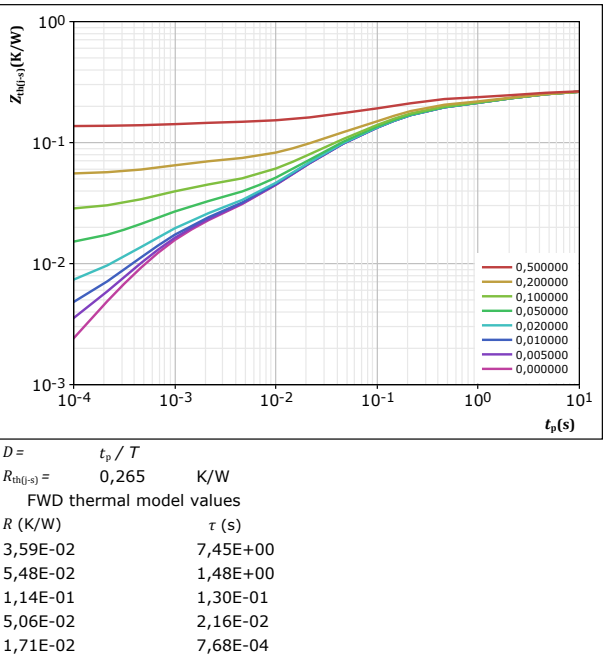


figure 16. FWD

Transient thermal impedance as a function of pulse width
 $Z_{th(j-s)} = f(t_p)$





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Boost Sw. Inv. Diode Characteristics

figure 17. FWD

Typical forward characteristics

$I_F = f(V_F)$

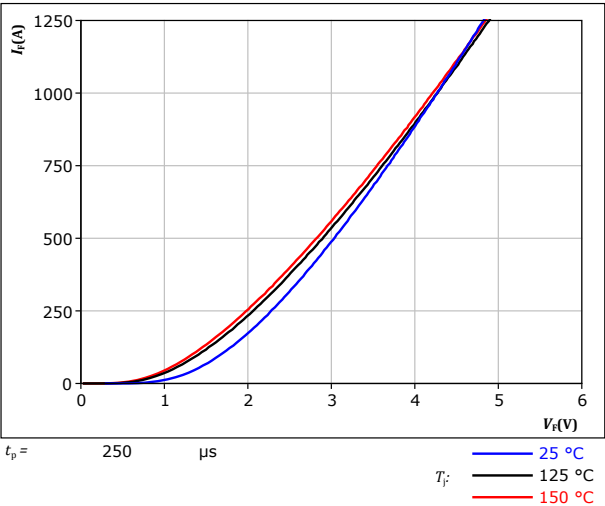
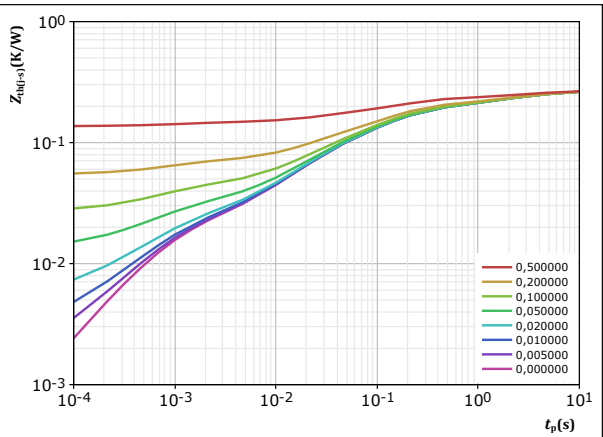


figure 18. FWD

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D =$	t_p / T
$R_{th(j-s)} =$	0,265 K/W
FWD thermal model values	
R (K/W)	τ (s)
3,59E-02	7,45E+00
5,48E-02	1,48E+00
1,14E-01	1,30E-01
5,06E-02	2,16E-02
1,71E-02	7,68E-04



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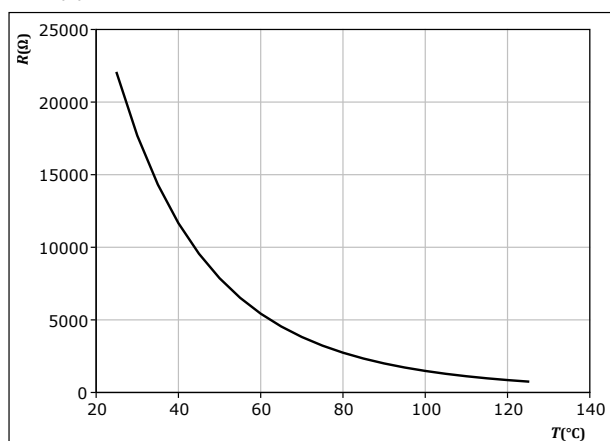
Thermistor Characteristics

figure 19.

Thermistor

Typical NTC characteristic as function of temperature

$$R_T = f(T)$$





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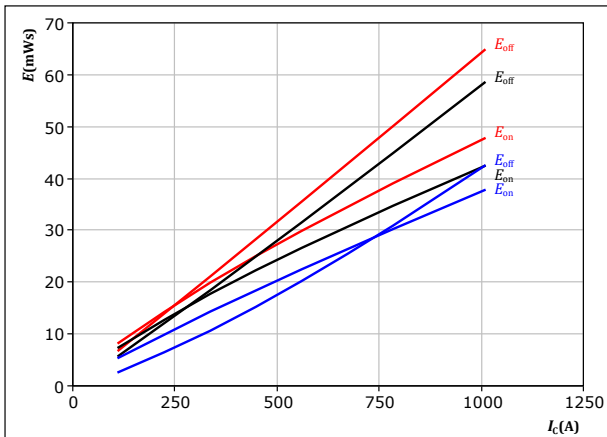
Buck Switching Characteristics

figure 20.

IGBT

Typical switching energy losses as a function of collector current

$$E = f(I_C)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω
 $R_{goff} = 2$ Ω

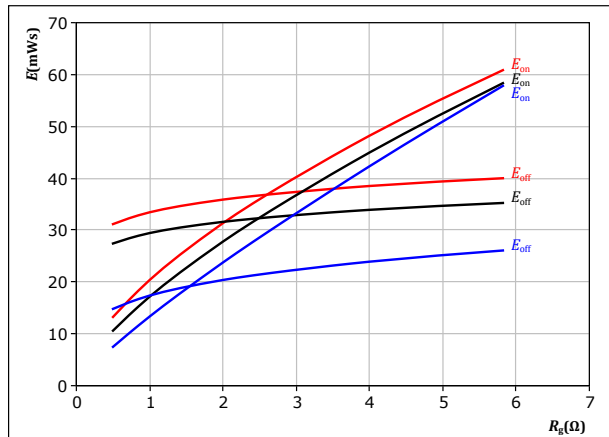
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 21.

IGBT

Typical switching energy losses as a function of IGBT turn on gate resistor

$$E = f(R_g)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

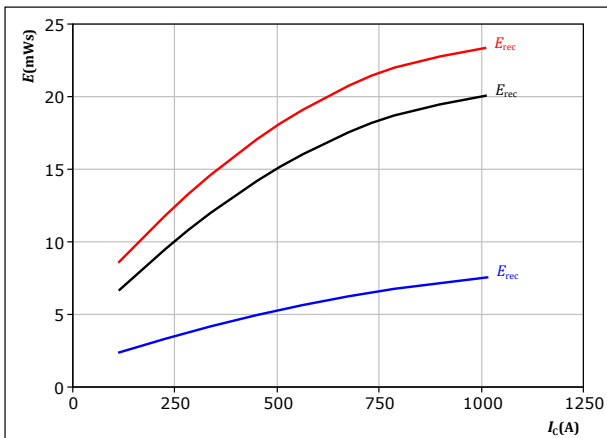
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 22.

FWD

Typical reverse recovered energy loss as a function of collector current

$$E_{rec} = f(I_C)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω

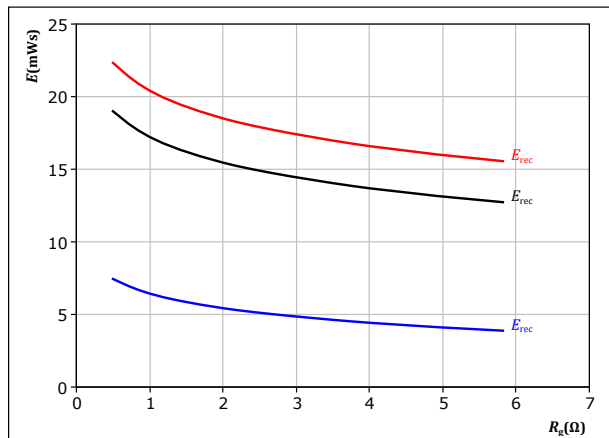
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 23.

FWD

Typical reverse recovered energy loss as a function of IGBT turn on gate resistor

$$E_{rec} = f(R_g)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

T_j :
— 25 °C
— 125 °C
— 150 °C



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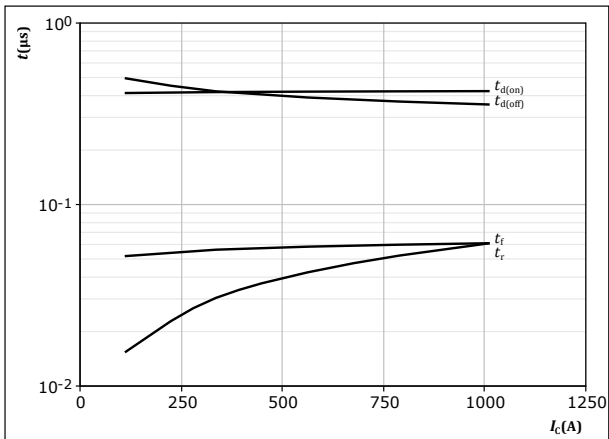
30-E312NIB560H710-PR40F07Z
datasheet

Buck Switching Characteristics

figure 24.

IGBT

Typical switching times as a function of collector current
 $t = f(I_C)$



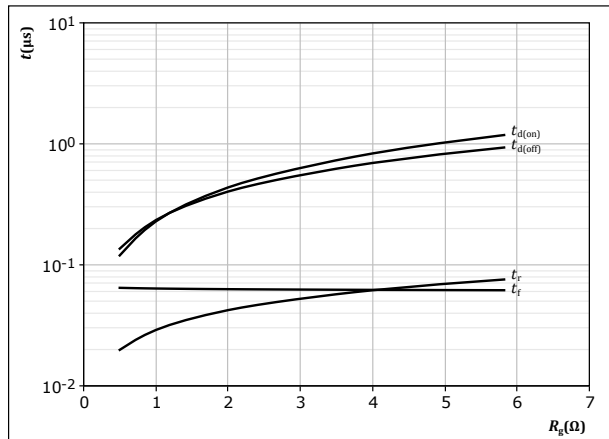
With an inductive load at

$T_j = 150$ °C
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω
 $R_{goff} = 2$ Ω

figure 25.

IGBT

Typical switching times as a function of IGBT turn on gate resistor
 $t = f(R_g)$



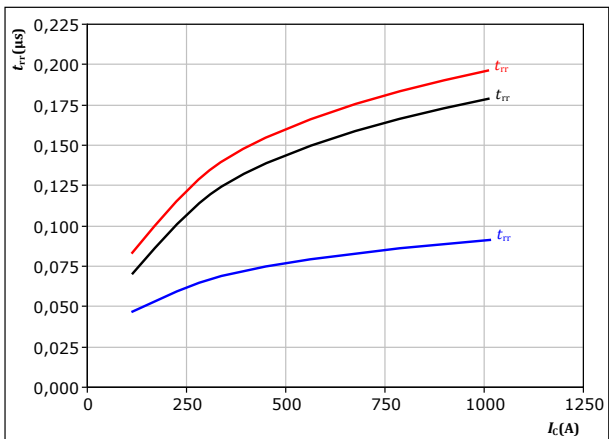
With an inductive load at

$T_j = 150$ °C
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

figure 26.

FWD

Typical reverse recovery time as a function of collector current
 $t_{rr} = f(I_C)$



With an inductive load at

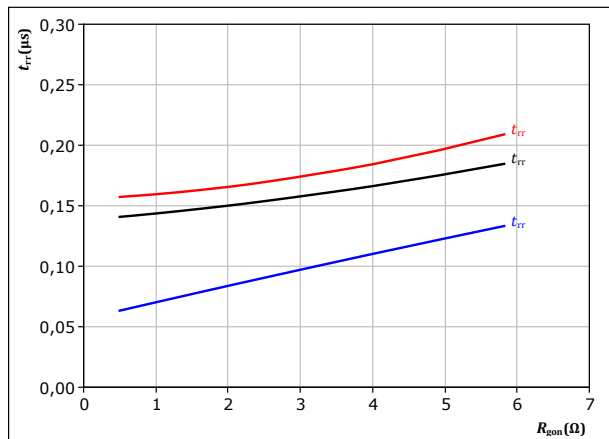
$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω

T_j : 25 °C
125 °C
150 °C

figure 27.

FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor
 $t_{rr} = f(R_{gon})$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

T_j : 25 °C
125 °C
150 °C



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datasheet

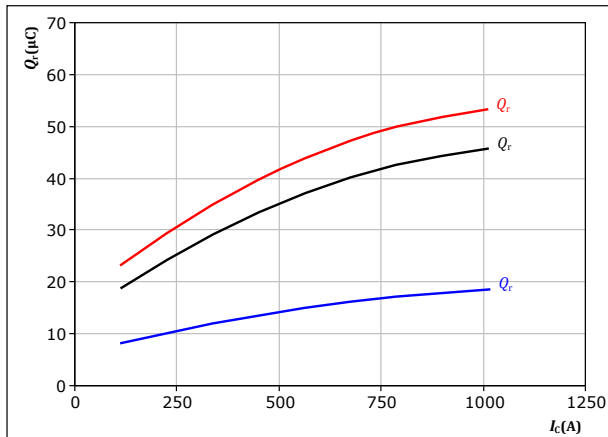
Buck Switching Characteristics

figure 28.

FWD

Typical recovered charge as a function of collector current

$$Q_r = f(I_c)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω

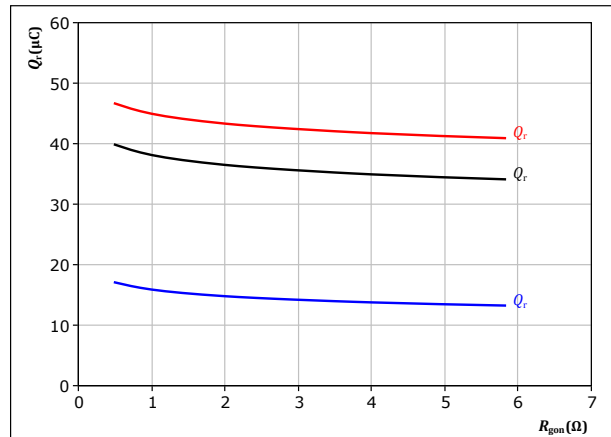
T_j : 25 °C
125 °C
150 °C

figure 29.

FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$$Q_r = f(R_{gon})$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 560$ A

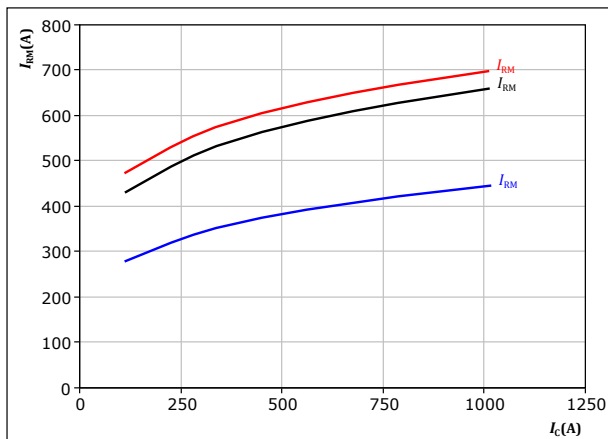
T_j : 25 °C
125 °C
150 °C

figure 30.

FWD

Typical peak reverse recovery current as a function of collector current

$$I_{RM} = f(I_c)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω

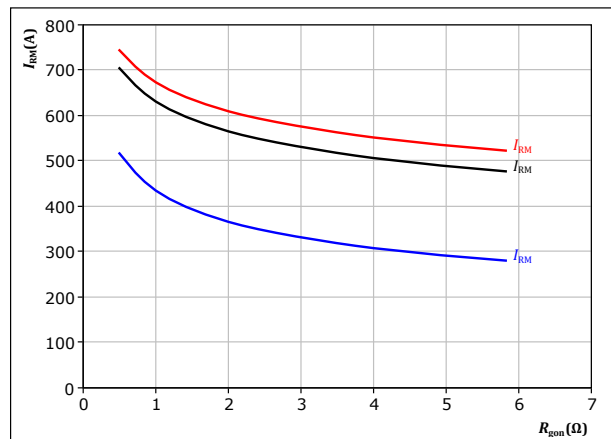
T_j : 25 °C
125 °C
150 °C

figure 31.

FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RM} = f(R_{gon})$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 560$ A

T_j : 25 °C
125 °C
150 °C



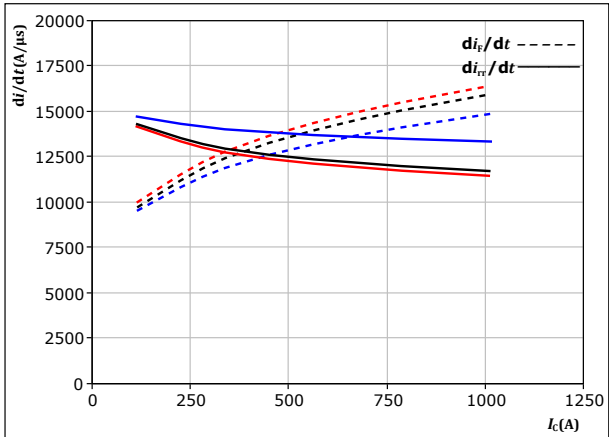
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datasheet

Buck Switching Characteristics

figure 32. FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_f/dt, di_r/dt = f(I_C)$



With an inductive load at

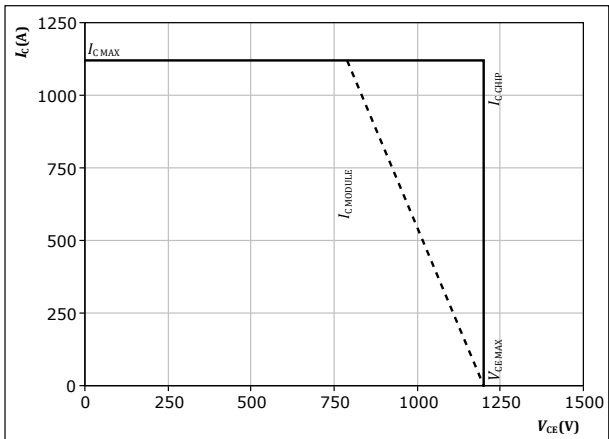
$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 2$ Ω

T_j :
— 25 °C
— 125 °C
— 150 °C

figure 34. IGBT

Reverse bias safe operating area

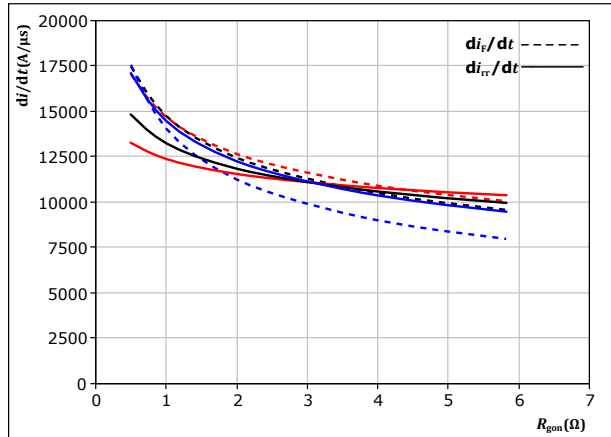
$I_C = f(V_{CE})$



At $T_j = 150$ °C
 $R_{gon} = 2$ Ω
 $R_{goff} = 2$ Ω

figure 33. FWD

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_r/dt = f(R_{gon})$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

T_j :
— 25 °C
— 125 °C
— 150 °C



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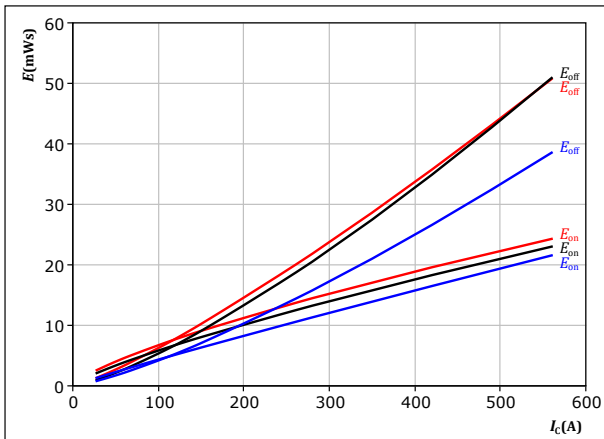
Boost Switching Characteristics

figure 35.

IGBT

Typical switching energy losses as a function of collector current

$$E = f(I_C)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω
 $R_{goff} = 16$ Ω

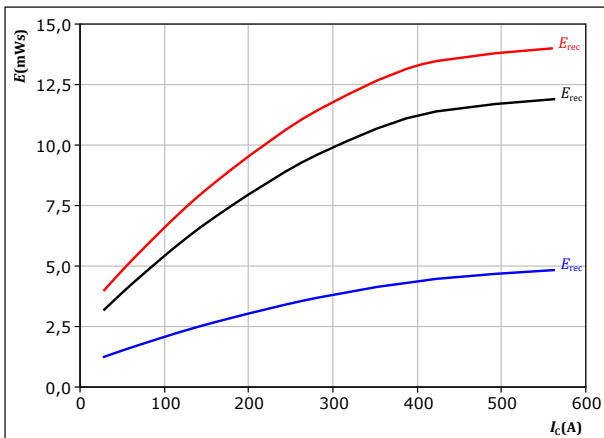
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 37.

FWD

Typical reverse recovered energy loss as a function of collector current

$$E_{rec} = f(I_C)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω

T_j :
— 25 °C
— 125 °C
— 150 °C



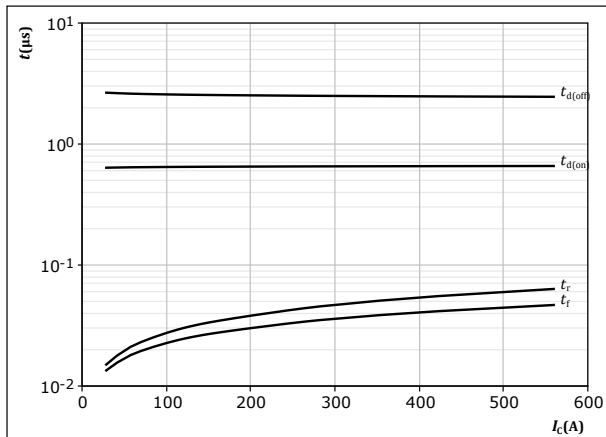
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datasheet

Boost Switching Characteristics

figure 39. IGBT

Typical switching times as a function of collector current
 $t = f(I_C)$

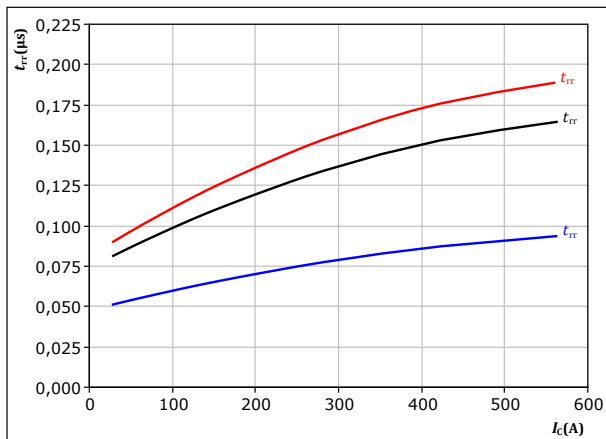


With an inductive load at

$T_j = 150$ °C
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω
 $R_{goff} = 16$ Ω

figure 41. FWD

Typical reverse recovery time as a function of collector current
 $t_{rr} = f(I_C)$



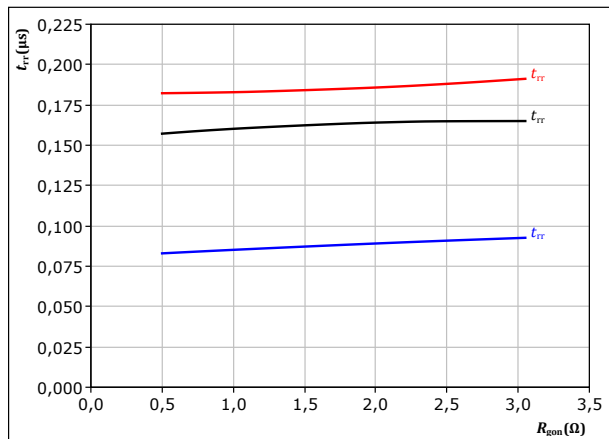
With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω

T_j :
— 25 °C
— 125 °C
— 150 °C

figure 42. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor
 $t_{rr} = f(R_{gon})$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

T_j :
— 25 °C
— 125 °C
— 150 °C



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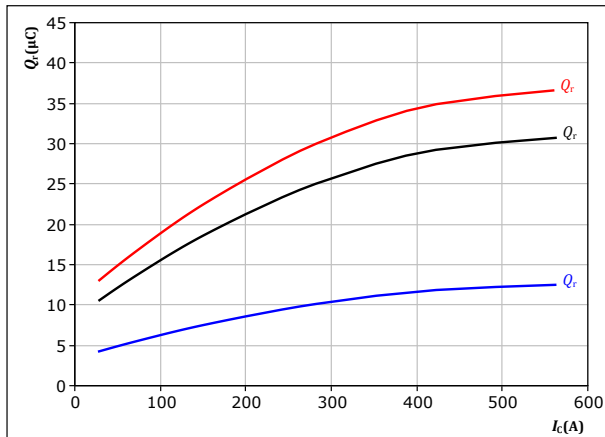
Boost Switching Characteristics

figure 43.

FWD

Typical recovered charge as a function of collector current

$$Q_r = f(I_c)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω

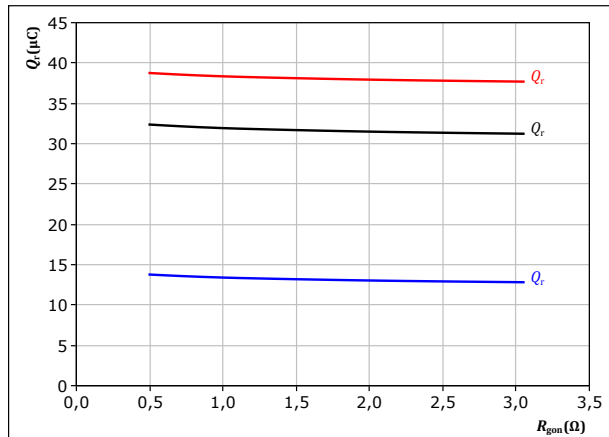
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 44.

FWD

Typical recovered charge as a function of IGBT turn on gate resistor

$$Q_r = f(R_{gon})$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 560$ A

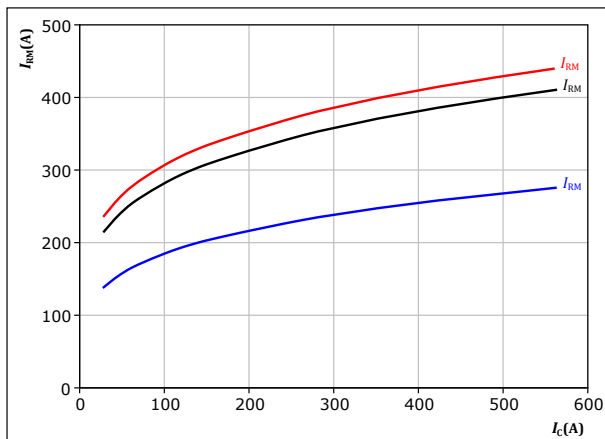
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 45.

FWD

Typical peak reverse recovery current as a function of collector current

$$I_{RM} = f(I_c)$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω

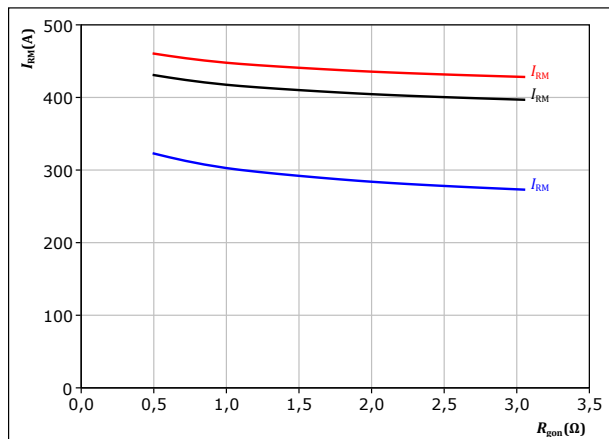
T_j :
— 25 °C
— 125 °C
— 150 °C

figure 46.

FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RM} = f(R_{gon})$$



With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_c = 560$ A

T_j :
— 25 °C
— 125 °C
— 150 °C



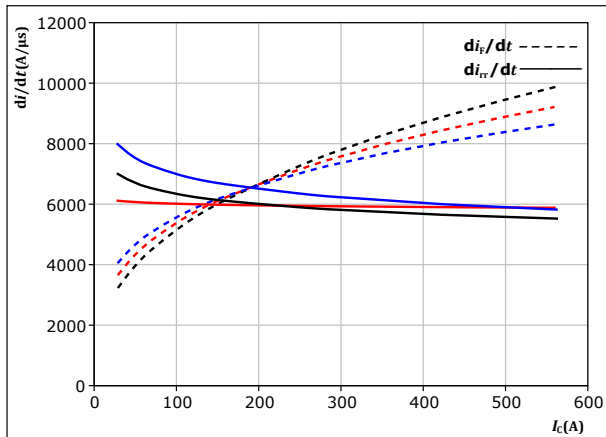
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Boost Switching Characteristics

figure 47. FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current
 $di_f/dt, di_r/dt = f(I_C)$



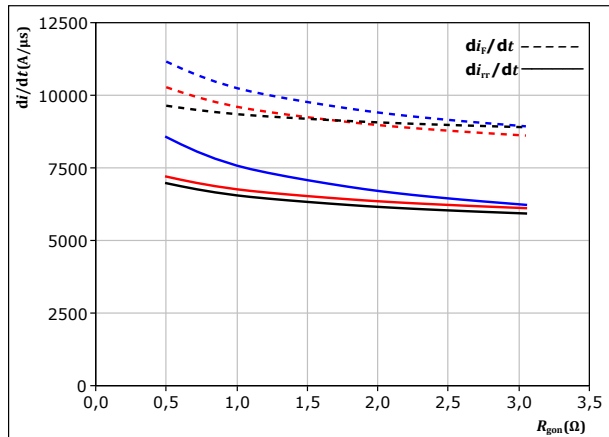
With an inductive load at

$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 3,05$ Ω

T_j :
— 25 °C
— 125 °C
— 150 °C

figure 48. FWD

Typical rate of fall of forward and reverse recovery current as a function of turn on gate resistor
 $di_f/dt, di_r/dt = f(R_{gon})$



With an inductive load at

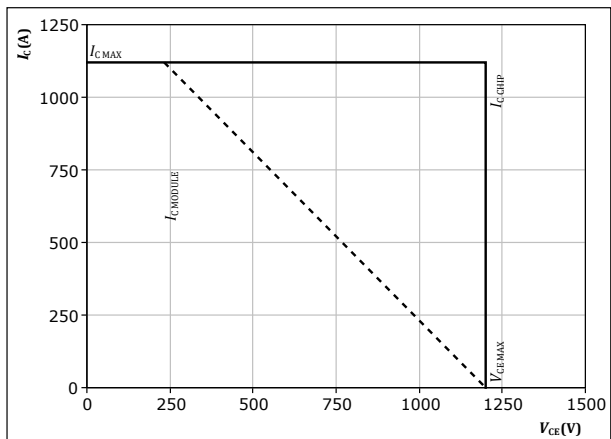
$V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $I_C = 560$ A

T_j :
— 25 °C
— 125 °C
— 150 °C

figure 49. IGBT

Reverse bias safe operating area

$I_C = f(V_{CE})$



At $T_j = 150$ °C
 $R_{gon} = 3,05$ Ω
 $R_{goff} = 16$ Ω



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Switching Definitions

figure 50.

IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff} (t_{Eoff} = integrating time for E_{off})

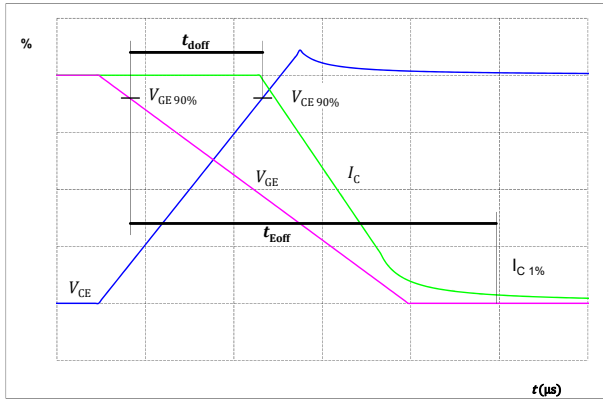


figure 51.

IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon} (t_{Eon} = integrating time for E_{on})

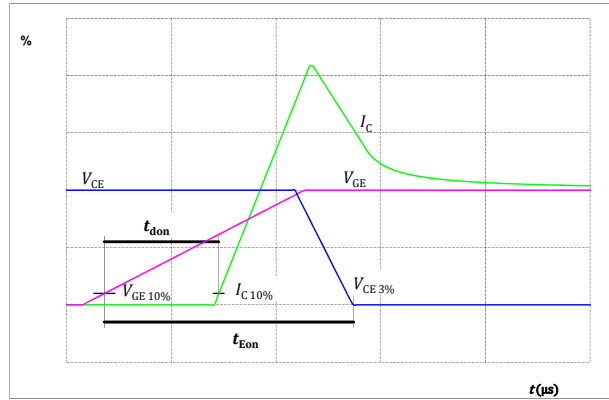


figure 52.

IGBT

Turn-off Switching Waveforms & definition of t_f

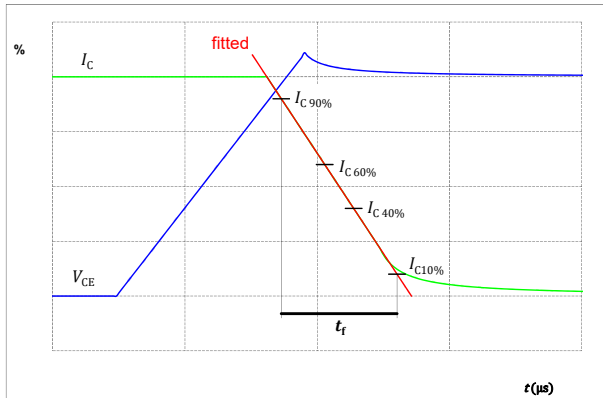
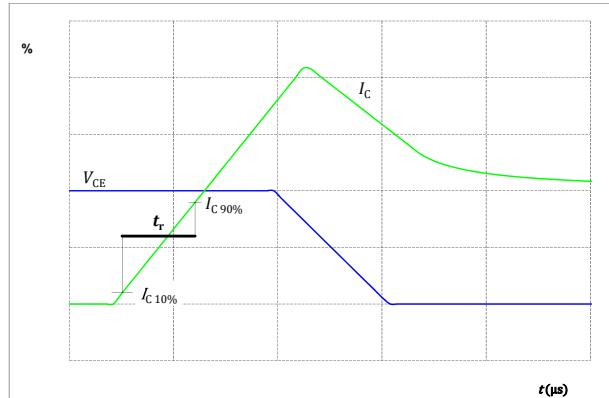


figure 53.

IGBT

Turn-on Switching Waveforms & definition of t_r





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Switching Definitions

figure 54.

FWD

Turn-off Switching Waveforms & definition of t_{rr}

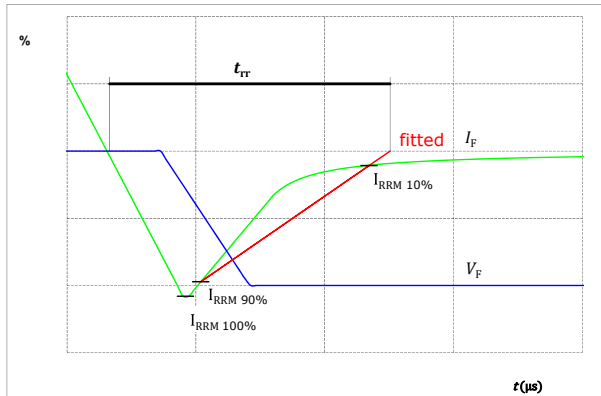
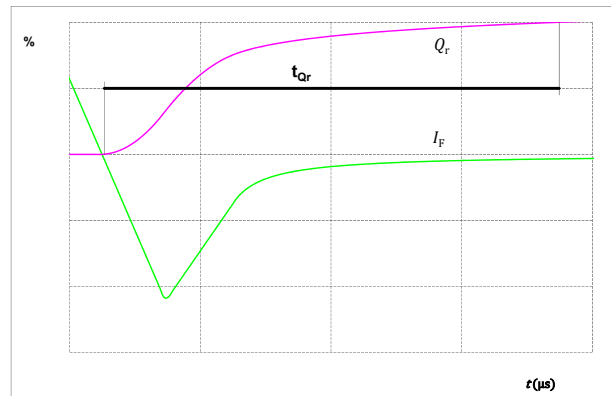


figure 55.

FWD

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)





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datasheet

Ordering Code	
Version	Ordering Code
Without thermal paste	30-E312NIB560H710-PR40F07Z
With thermal paste (5,2 W/mK, PTM6000HV)	30-E312NIB560H710-PR40F07Z-/7/

Marking						
	Text	Name		Date code	UL & VIN	Lot
		NN-NNNNNNNNNNNNNN- TTTTUVV		WWYY	UL VIN	LLLL
	Datamatrix	Type&Ver	Lot number	Serial	Date code	Serial
		TTTTTUVV	LLLL	SSSS	WWYY	SSSS

Outline				
Pin table [mm]				Function
Pin	X	Y		
1	56,16	0		DC-
2	59,36	0		DC-
3	62,56	0		DC-
4	65,76	0		DC-
5	68,96	0		DC-
6	72,16	0		DC-
7	25,6	0		GND1
8	28,8	0		GND1
9	32	0		GND1
10	40,16	0		GND2
11	43,36	0		GND2
12	46,56	0		GND2
13	0	0		DC+
14	3,2	0		DC+
15	6,4	0		DC+
16	9,6	0		DC+
17	12,8	0		DC+
18	16	0		DC+
19	16	48		Ph1
20	19,2	48		Ph1
21	22,4	48		Ph1
22	25,6	48		Ph1
23	28,8	48		Ph1
24	32	48		Ph1
25	40,16	44,8		Ph2
26	43,36	44,8		Ph2
27	46,56	44,8		Ph2
28	40,16	48		Ph2
29	43,36	48		Ph2
30	46,56	48		Ph2
31	62,56	28,8		N
32	9,6	25,6		P
33	9,6	19,2		G11
34	9,6	22,4		S11
35	62,56	9,6		G12
36	62,56	6,4		S12
37	0	44,8		G13
38	0	48		S13
39	72,16	48		G14
40	68,96	48		S14
41	56,16	48		Therm1
42	59,36	48		Therm2

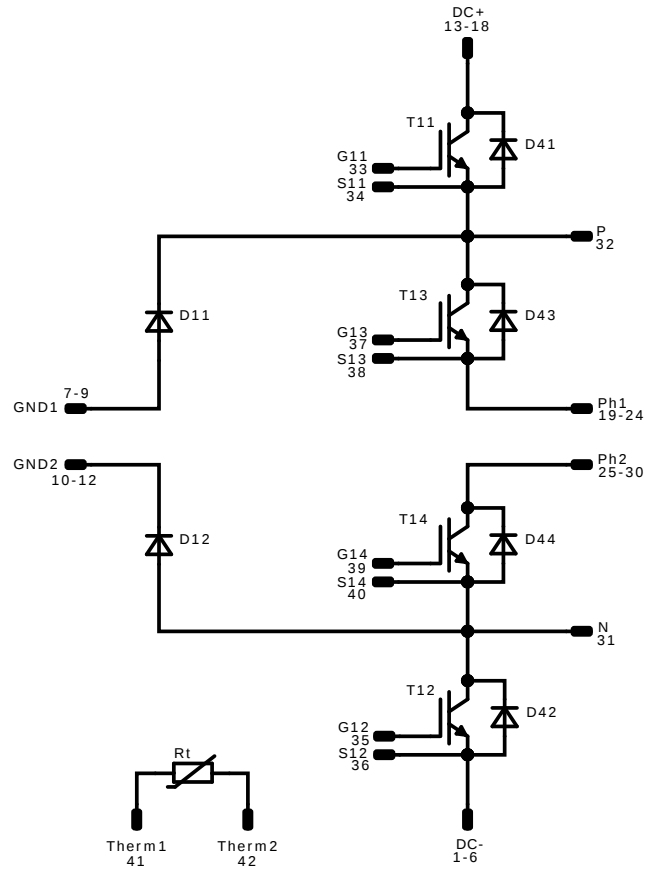


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datasheet

Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T11, T12	IGBT	1200 V	560 A	Buck Switch	
D11, D12	FWD	1200 V	560 A	Buck Diode	
T13, T14	IGBT	1200 V	560 A	Boost Switch	
D42, D41	FWD	1200 V	560 A	Boost Diode	
D43, D44	FWD	1200 V	560 A	Boost Sw. Inv. Diode	
Rt	Thermistor			Thermistor	



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datasheet

Packaging instruction				
Standard packaging quantity (SPQ) 24	>SPQ	Standard	<SPQ	Sample
Handling instruction				
Handling instructions for <i>flow</i> E3BP packages see vincotech.com website.				
Package data				
Package data for <i>flow</i> E3BP packages see vincotech.com website.				
Vincotech thermistor reference				
See Vincotech thermistor reference table at vincotech.com website.				
UL recognition and file number				
This device is UL 1557 recognized under E192116 up to a junction temperature under switching condition $T_{j,sp}=175^{\circ}\text{C}$ and up to 4000VAC/1min isolation voltage. For more information see vincotech.com website.				

Document No.:	Date:	Modification:	Pages
30-E312NIB560H710-PR40F07Z-D1-14	30 May. 2025	Initial Release	
30-E312NIB560H710-PR40F07Z-D2-14	10 Jun. 2025	Update Dynamic Characteristic Values table of Buck Switch Update Dynamic Characteristic Values table of Buck Diode Update Buck Switching Characteristics charts	

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.